

# P-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ ) Typ.	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (TYP.)			
-60	0.058 at V <sub>GS</sub> = -10 V	-6.5	10.1 nC			
	0.070 at V <sub>GS</sub> = -4.5 V	-5.1	10.1110			

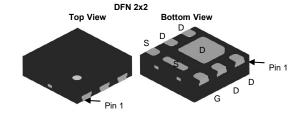
#### **FEATURES**

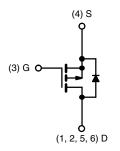
- TrenchFET® power MOSFET
- 100 % R<sub>g</sub> and UIS tested



## **APPLICATIONS**

- Load switches
- DC/DC converter





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (TA	= 25 °C, unless other	wise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V <sub>DS</sub>	-60	V		
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		-6.5		
Continuous Proin Current (T. – 150 °C)	T <sub>C</sub> = 70 °C		-4.5		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	-3.8 <sup>a,b</sup>		
	T <sub>A</sub> = 70 °C		-3.1 <sup>a,b</sup>	Α	
Pulsed Drain Current (t = 100 μs)	Pulsed Drain Current (t = 100 μs)			A	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		-3.5		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	-1.7 <sup>a,b</sup>		
Avalanche Current L = 0.1 mH		I <sub>AS</sub>	-15		
Single-Pulse Avalanche Energy	E <sub>AS</sub>	11.25	mJ		
	T <sub>C</sub> = 25 °C		4.2		
Mayimum Dayyar Dissination	T <sub>C</sub> = 70 °C		2.7	w	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2 <sup>a,b</sup>	VV	
	T <sub>A</sub> = 70 °C		1.3 <sup>a,b</sup>		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C		

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient a,c	t ≤ 10 s	R <sub>thJA</sub>	40	62.5	°C/W		
Maximum Junction-to-Foot	Steady State	$R_{thJF}$	25	30	C/VV		

#### Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 110 °C/W.
- d. Based on  $T_C$  = 25 °C.

服务热线:400-655-8788

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static					l	1
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$		-	-6.7	-	1400
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = -250  \mu A$	-	4.3	-	mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-1	-	-3	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zava Cata Valta da Busin Comunit	1	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V	-	-	-1	μA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	-5	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	-30	-	-	Α
Dunin Course On Chata Basistana 3	Ъ	$V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	-	0.058	-	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -2.8 \text{ A}$	-	0.070	-	
Forward Transconductance a	9 <sub>fs</sub>	$V_{DS} = -30 \text{ V}, I_D = -3.5 \text{ A}$	-	11	-	S
Dynamic <sup>b</sup>				I.	•	
Input Capacitance	C <sub>iss</sub>			832	-	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	88	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	63	-	
Total Cata Charge	$Q_g \qquad V_{DS} = -30 \text{ V, } V_{GS}$	$V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$	-	20	30	nC
Total Gate Charge			-	10.1	15.2	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.5 \text{ A}$	-	3.3	-	
Gate-Drain Charge	$Q_{gd}$		-	3.9	-	
Gate Resistance	$R_g$	f = 1 MHz	1.8	9	18	Ω
Turn-On Delay Time	t <sub>d(on)</sub>		-	8	16	
Rise Time	t <sub>r</sub>	$V_{DD}$ = -30 V, $R_L$ = 10.7 $\Omega$	-	6	12	1
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D\cong$ -2.8 A, $V_{GEN}=$ -10 V, $R_g=$ 1 $\Omega$	-	35	53	
Fall Time	t <sub>f</sub>		-	16	24	
Turn-On Delay Time	t <sub>d(on)</sub>		-	40	60	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = -30 V, $R_L$ = 10.7 $\Omega$	-	28	42	- - -
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D\cong$ -2.8 A, $V_{GEN}$ = -4.5 V, $R_g$ = 1 $\Omega$	-	31	47	
Fall Time	t <sub>f</sub>		-	15	23	
Drain-Source Body Diode Characterist	ics					
Continous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	-3.5	^
Pulse Diode Forward Current (t = 100 µs)	I <sub>SM</sub>		-	-	-20	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = -2.8 A, V <sub>GS</sub> = 0 V	-	-0.85	-1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>		-	32	48	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = -2.8 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s},$	-	45	68	nC
Reverse Recovery Fall Time			-	24	-	ns
Reverse Recovery Rise Time	t <sub>b</sub>	1		8	-	

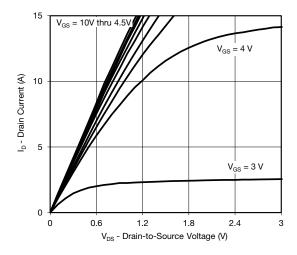
#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

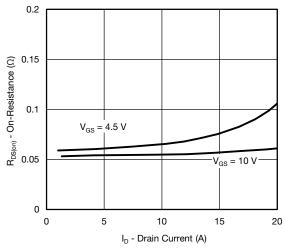
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



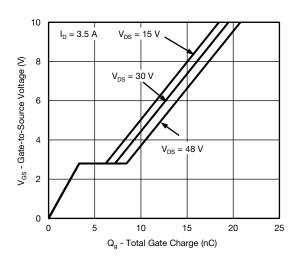
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



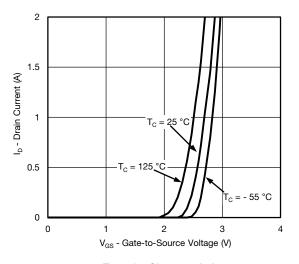
#### **Output Characteristics**



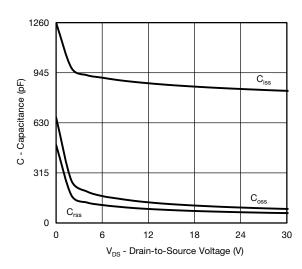
On-Resistance vs. Drain Current



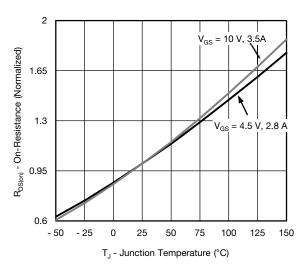
**Gate Charge** 



**Transfer Characteristics** 



Capacitance

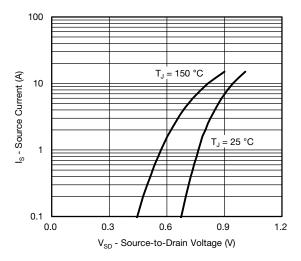


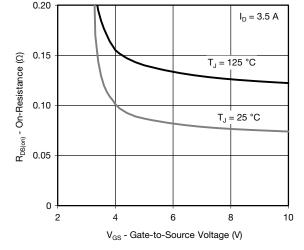
On-Resistance vs. Junction Temperature

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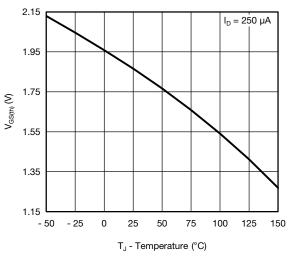
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

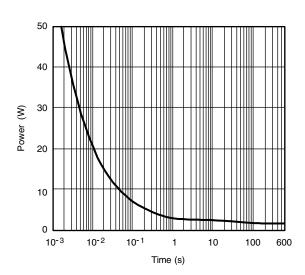




#### Source-Drain Diode Forward Voltage

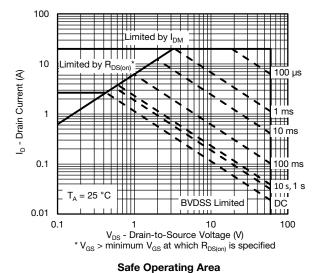
On-Resistance vs. Gate-to-Source Voltage





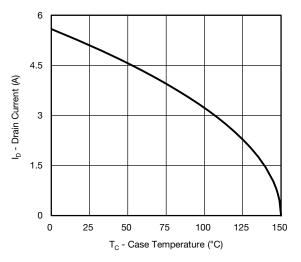
**Threshold Voltage** 

Single Pulse Power, Junction-to-Ambient

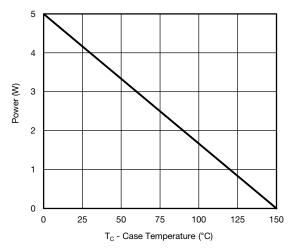




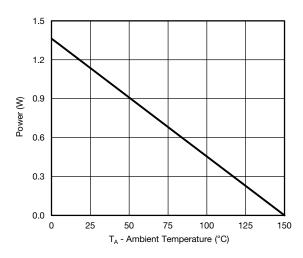
### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### **Current Derating\***







Power Derating, Junction-to-Ambient

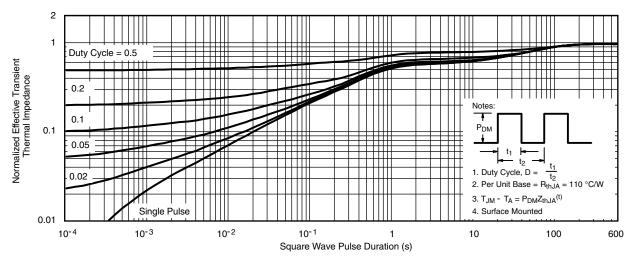
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J \text{ (max.)}} = 150 \,^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

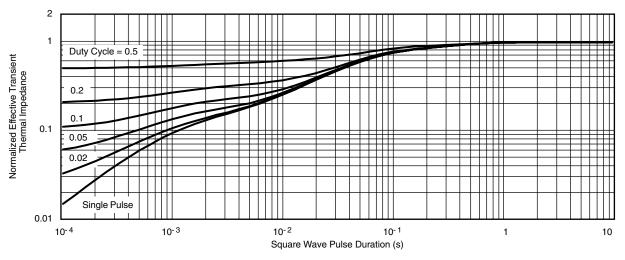
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

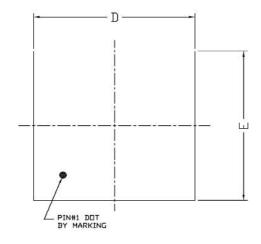


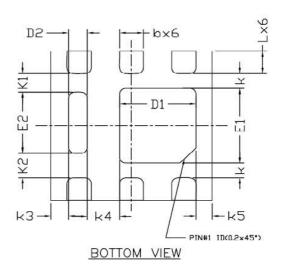
Normalized Thermal Transient Impedance, Junction-to-Foot

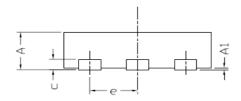


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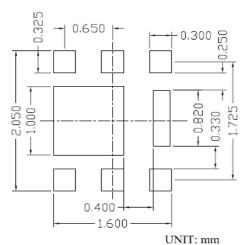
## DFN2x2 \_6L\_EP1\_S PACKAGE OUTLINE







#### RECOMMENDED LAND PATTERN



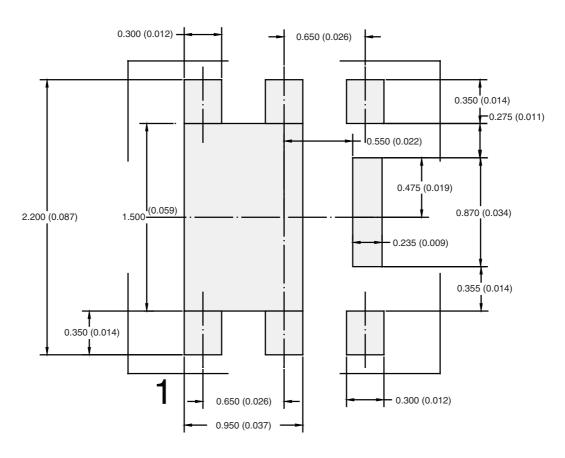
П	DD (EX)	SIONS IN MILLI	A CETTER C	DD.	ENSIONS IN INC	circe
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX
A	0. 50	0. 55	0.60	0.020	0.022	0.024
A1	0.00		0.05	0.000		0.002
ь	0.25	0.30	0.35	0.010	0.012	0.014
с	0, 152 REF				0.006 REF	
D	1.90	2.00	2.10	0.075	0.079	0.083
D1	0.85	0. 95	1.05	0.033	0.037	0.041
D2	0.13	0.23	0.33	0.005	0.009	0.013
E	1.90	2.00	2.10	0.075	0.079	0.083
E1	0.90	1.00	1.10	0.035	0.039	0.043
E2	0.72	0.82	0. 92	0.028	0.032	0.036
e	0.65 BSC			0.026 BSC		
K	0. 20 BSC			0.008 BSC		
K1	0. 25 BSC			0.010 BSC		
K2	0. 33 BSC			0.013 BSC		
K3	0. 22 BSC			0.009 BSC		
K4	0.40 BSC			0.016 BSC		
K5	0. 20 BSC			0.008 BSC		
L	0.25	0.30	0.35	0.010	0.012	0.014

NOTE

1. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



## **RECOMMENDED PAD LAYOUT FOR DFN2X2**



Dimensions in mm/(Inches)



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